

**Search Notes**

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Examiner

Jinhee J. Lee

Applicant(s)/Patent under  
Reexamination

SHIMIZU, HAJIME

Art Unit

2175

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
plus search	2/29/2008	LEE